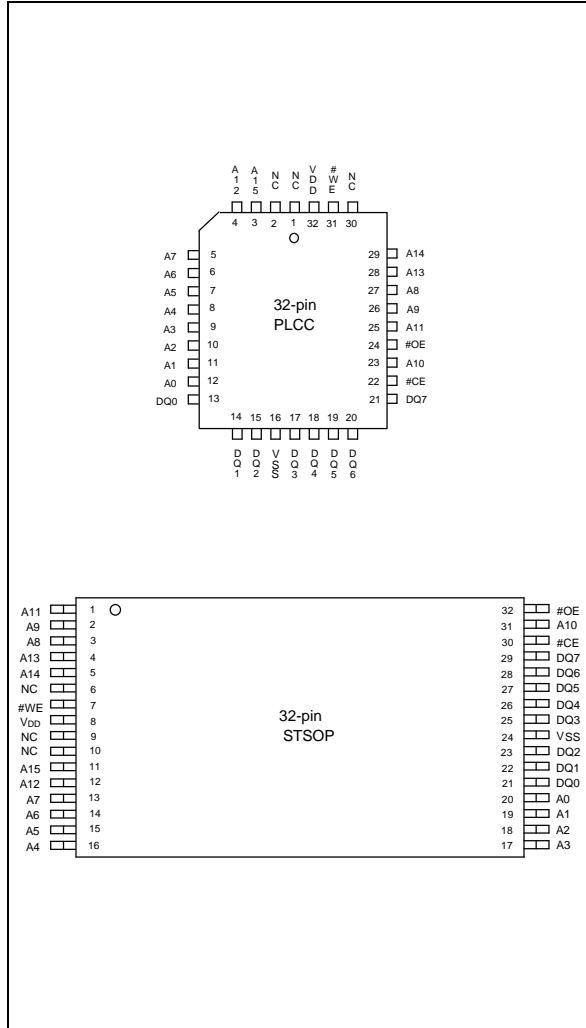# 64K ´ 8 CMOS FLASH MEMORY

1. GENERAL DESCRIPTION

The W39L512 is a 512Kbit, 3.3-volt only CMOS flash memory organized as 64K × 8 bits. For flexible erase capability, the 512Kbits of data are divided into 16 small even pages with 4 Kbytes. The byte-wide (× 8) data appears on DQ7 − DQ0. The device can be programmed and erased in-system with a standard 3.3V power supply. A 12-volt V_{PP} is not required. The unique cell architecture of the W39L512 results in fast program/erase operations with extremely low current consumption (compared to other comparable 3.3-volt flash memory products). The device can also be programmed and erased by using standard EPROM programmers.
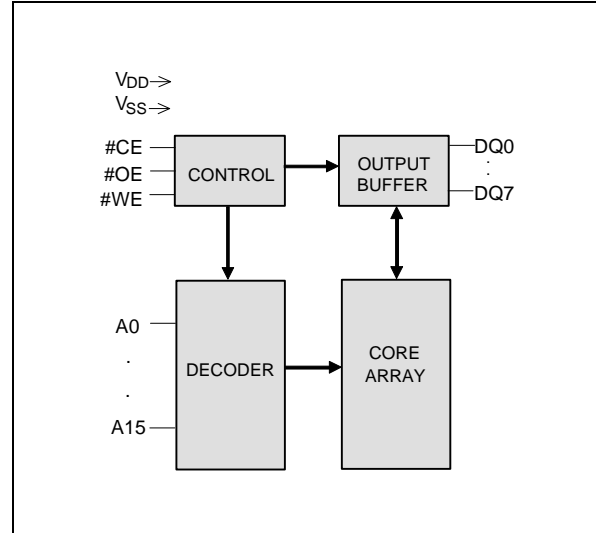
2. FEATURES

- Single 3.3-volt operations
  - 3.3-volt Read
  - 3.3-volt Erase
  - 3.3-volt Program
- Fast Program operation:
  - Byte-by-Byte programming: 50 µS (max.)
- Fast Erase operation: 100 mS (max.)
- Read access time: 70/90 nS
- 16 even pages with 4K bytes
- Any individual page can be erased
- Hardware protection:
  - Optional 8K byte Top/Bottom Boot Block with lockout protection

- Flexible 4K-page size can be used as Parameter Blocks
- Typical program/erase cycles:
  - 1K/10K
- Twenty-year data retention
- Low power consumption
  - Active current: 10 mA (typ.)
  - Standby current: 15 µA (typ.)
- End of program detection
  - Software method: Toggle bit/Data polling
- TTL compatible I/O
- JEDEC standard byte-wide pinouts
- Available packages: 32-pin PLCC and 32-pin STSOP (8 x 14 mm)

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3. PIN CONFIGURATIONS

32-pin
PLCC

A7 5
A6 6
A5 7
A4 8
A3 9
A2 10
A1 11
A0 12
DQ0 13

A12 A15 NC NC VDD #WE NC
4 3 2 1 32 31 30

29 A14
28 A13
27 A8
26 A9
25 A11
24 #OE
23 A10
22 #CE
21 DQ7

14 15 16 17 18 19 20
DQ1 DQ2 VSS DQ3 DQ4 DQ5 DQ6

32-pin
STSOP

A11 1
A9   2
A8   3
A13 4
A14 5
NC   6
#WE 7
VDD 8
NC   9
NC   10
A15 11
A12 12
A7   13
A6   14
A5   15
A4   16

32 #OE
31 A10
30 #CE
29 DQ7
28 DQ6
27 DQ5
26 DQ4
25 DQ3
24 VSS
23 DQ2
22 DQ1
21 DQ0
20 A0
19 A1
18 A2
17 A3

4. BLOCK DIAGRAM

VDD →
VSS →

#CE
#OE
#WE

CONTROL

OUTPUT
BUFFER

DQ0
:
DQ7

A0
.
.
A15

DECODER

CORE
ARRAY

5. PIN DESCRIPTION

SYMBOL	PIN NAME
A0 – A15	Address Inputs
DQ0 – DQ7	Data Inputs/Outputs
#CE	Chip Enable
#OE	Output Enable
#WE	Write Enable
VDD	Power Supply
VSS	Ground
NC	No Connections

6. FUNCTIONAL DESCRIPTION

Device Bus Operation

Read Mode

The read operation of the W39L512 is controlled by #CE and #OE, both of which have to be low for the host to obtain data from the outputs. #CE is used for device selection. When #CE is high, the chip is de-selected and only standby power will be consumed. #OE is the output control and is used to gate data from the output pins. The data bus is in high impedance state when either #CE or #OE is high. Refer to the timing waveforms for further details.

Write Mode

Device erasure and programming are accomplished via the command register. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device.

The command register itself does not occupy any addressable memory location. The register is a latch used to store the commands, along with the address and data information needed to execute the command. The command register is written to bring #WE to logic low state, while #CE is at logic low state and #OE is at logic high state. Addresses are latched on the falling edge of #WE or #CE, whichever happens later; while data is latched on the rising edge of #WE or #CE, whichever happens first. Standard microprocessor write timings are used.

Refer to AC Write Characteristics and the Erase/Programming Waveforms for specific timing parameters.

Standby Mode

There are two ways to implement the standby mode on the W39L512 device, both using the #CE pin.

A CMOS standby mode is achieved with the #CE input held at $V_{DD} \pm 0.3V$. Under this condition the current is typically reduced to less than 20 μA. A TTL standby mode is achieved with the #CE pin held at V_{IH}.

Under this condition the current is typically reduced to 2 mA.

In the standby mode the outputs are in the high impedance state, independent of the #OE input.

Output Disable Mode

With the #OE input at a logic high level (V_{IH}), output from the device is disabled. This will cause the output pins to be in a high impedance state.

Auto-select Mode

The auto-select mode allows the reading of a binary code from the device and will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional over the entire temperature range of the device.

To activate this mode, the programming equipment must force V_{ID} (11.5V to 12.5V) on address pin A9. Two identifier bytes may then be sequenced from the device outputs by toggling address A0 from V_{IL} to V_{IH}. All addresses are don't cares except A0 and A1 (see "Auto-select Codes").

The manufacturer and device codes may also be read via the command register, for instance, when the W39L512 is erased or programmed in a system without access to high voltage on the A9 pin. The command sequence is illustrated in "Auto-select Codes".

Byte 0 (A0 = V$_{IL}$) represents the manufacturer's code (Winbond = DAH) and byte 1 (A0 = V$_{IH}$) the device identifier code (W39L512 = 38H). All identifiers for manufacturer and device will exhibit odd parity with DQ7 defined as the parity bit. In order to read the proper device codes when executing the Auto-select, A1 must be low state.

Data Protection

The W39L512 is designed to offer protection against accidental erasure or programming caused by spurious system level signals that may exist during power transitions. During power up the device automatically resets the internal state machine in the Read mode. Also, with its control register architecture, alteration of the memory contents only occurs after successful completion of specific multi-bus cycle command sequences. The device also incorporates several features to prevent inadvertent write cycles resulting from V$_{DD}$ power-up and power-down transitions or system noise.

Boot Block Operation

There are two alternatives to set the boot block. The 8K-byte in the top/bottom location of this device can be locked as boot block, which can be used to store boot codes. It is located in the last 8K bytes or first 8K bytes of the memory with the address range from E000(hex) to FFFF(hex) for top location or 0000(hex) to 1FFF(hex) for bottom location.

See Command Codes for Boot Block Lockout Enable for the specific code. Once this feature is set the data for the designated block cannot be erased or programmed (programming lockout), other memory locations can be changed by the regular programming method.

In order to detect whether the boot block feature is set on the first/last 8K-byte block or not, users can perform software command sequence: enter the product identification mode (see Command Codes for Identification/Boot Block Lockout Detection for specific code), and then read from address 0002(hex) for first(bottom) location or FFF2(hex) for last(top) location.   If the DQ0/DQ1 of output data is "1," the 8Kbytes boot block programming lockout feature will be activated; if the DQ0/DQ1 of output data is "0," the lockout feature will be inactivated and the block can be erased/programmed.

To return to normal operation, perform a three-byte command sequence (or an alternate single-byte command) to exit the identification mode. For the specific code, see Command Codes for Identification/Boot Block Lockout Detection.

Low V$_{DD}$ Inhibit

To avoid initiation of a write cycle during V$_{DD}$ power-up and power-down, the W39L512 locks out when V$_{DD}$ < 2.0V (see DC Characteristics section for voltages). The write and read operations are inhibited when V$_{DD}$ is less than 2.0V typical. The W39L512 ignores all write and read operations until V$_{DD}$ > 2,0V. The user must ensure that the control pins are in the correct logic state when V$_{DD}$ > 2.0V to prevent unintentional writes.

Write Pulse "Glitch" Protection

Noise pulses of less than 10 nS (typical) on #OE, #CE, or #WE will not initiate a write cycle.

Logical Inhibit

Writing is inhibited by holding any one of #OE = V_{IL}, #CE = V_{IH}, or #WE = V_{IH}. To initiate a write cycle #CE and #WE must be a logical zero while #OE is a logical one.

Power-up Write Inhibit

Power-up of the device with #WE = #CE = VIL and #OE = V_{IH} will not accept commands on the rising edge of #WE except 5mS delay (see the power up timing in AC Characteristics). The internal state machine is automatically reset to the read mode on power-up.

Command Definitions

Device operations are selected by writing specific address and data sequences into the command register. Writing incorrect address and data values or writing them in the improper sequence will reset the device to the read mode. "Command Definitions" defines the valid register command sequences.

Read Command

The device will automatically power-up in the read state. In this case, a command sequence is not required to read data. Standard microprocessor read cycles will retrieve array data. This default value ensures that no spurious alteration of the memory content occurs during the power transition.

The device will automatically returns to read state after completing an Embedded Program or Embedded Erase algorithm.

Refer to the AC Read Characteristics and Waveforms for the specific timing parameters.

Auto-select Command

Flash memories are intended for use in applications where the local CPU can alter memory contents. As such, manufacture and device codes must be accessible while the device resides in the target system. PROM programmers typically access the signature codes by raising A9 to a high voltage. However, multiplexing high voltage onto the address lines is not generally a desirable system design practice.

The device contains an auto-select command operation to supplement traditional PROM programming methodology. The operation is initiated by writing the auto-select command sequence into the command register. Following the command write, a read cycle from address XX00H retrieves the manufacture code of DAH. A read cycle from address XX01H returns the device code (W39L512 = 38H).

To terminate the operation, it is necessary to write the auto-select exit command sequence into the register.

Byte Program Command

The device is programmed on a byte-by-byte basis. Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two "unlock" write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded program algorithm. Addresses are latched on the falling edge of #CE or #WE, whichever happens later and the data is latched on the rising edge of #CE or #WE, whichever happens first. The rising edge of #CE or #WE (whichever happens first) begins programming using the Embedded Program Algorithm.

Upon executing the algorithm, the system is not required to provide further controls or timings. The device will automatically provide adequate internally generated program pulses and verify the programmed cell margin.

The automatic programming operation is completed when the data on DQ7 (also used as Data Polling) is equivalent to the data written to this bit at which time the device returns to the read mode and addresses are no longer latched (see "Hardware Sequence Flags"). Therefore, the device requires that a valid address to the device be supplied by the system at this particular instance of time for Data Polling operations. Data Polling must be performed at the memory location which is being programmed.

Any commands written to the chip during the Embedded Program Algorithm will be ignored. If a hardware reset occurs during the programming operation, the data at that particular location will be corrupted.

Programming is allowed in any sequence and across page boundaries. Beware that a data "0" cannot be programmed back to a "1". Attempting to program 0 back to 1, the toggle bit will stop toggling. Only erase operations can convert "0"s to "1"s.

Refer to the Programming Command Flow Chart using typical command strings and bus operations.

Chip Erase Command

Chip erase is a six-bus-cycle operation. There are two "unlock" write cycles, followed by writing the "set-up" command. Two more "unlock" write cycles are asserted, followed by the chip erase command.

Chip erase does not require the user to program the device prior to erase. Upon executing the Embedded Erase Algorithm command sequence the device will automatically erase and verify the entire memory for an all one data pattern. The erase is performed sequentially on each pages at the same time (see "Feature"). The system is not required to provide any controls or timings during these operations.

The automatic erase begins on the rising edge of the last #WE pulse in the command sequence and terminates when the data on DQ7 is "1" at which time the device returns to read the mode.

Refer to the Erase Command Flow Chart using typical command strings and bus operations.

Page Erase Command

Page erase is a six bus cycles operation. There are two "unlock" write cycles, followed by writing the "set-up" command. Two more "unlock" write cycles then follows by the page erase command. The page address (any address location within the desired page) is latched on the falling edge of #WE, while the command (50H) is latched on the rising edge of #WE.

Page erase does not require the user to program the device prior to erase. When erasing a page, the remaining unselected pages are not affected. The system is not required to provide any controls or timings during these operations.

The automatic page erase begins after the erase command is completed, right from the rising edge of the #WE pulse for the last page erase command pulse and terminates when the data on DQ7, Data Polling, is "1" at which time the device returns to the read mode. Data Polling must be performed at an address within any of the pages being erased.

Refer to the Erase Command flow Chart using typical command strings and bus operations.

Write Operation Status

DQ7: Data Polling

The W39L512 device features Data Polling as a method to indicate to the host that the embedded algorithms are in progress or completed.

During the Embedded Program Algorithm, an attempt to read the device will produce the complement of the data last written to DQ7. Upon completion of the Embedded Program Algorithm, an attempt to read the device will produce the true data last written to DQ7.

During the Embedded Erase Algorithm, an attempt to read the device will produce a "0" at the DQ7 output. Upon completion of the Embedded Erase Algorithm, an attempt to read the device will produce a "1" at the DQ7 output.

For chip erase, the Data Polling is valid after the rising edge of the sixth pulse in the six #WE write pulse sequences. For page erase, the Data Polling is valid after the last rising edge of the page erase #WE pulse. Data Polling must be performed at addresses within any of the pages being erased. Otherwise, the status may not be valid.

Just prior to the completion of Embedded Algorithm operations DQ7 may change asynchronously while the output enable (#OE) is asserted low. This means that the device is driving status information on DQ7 at one instant of time and then that byte′s valid data at the next instant of time. Depending on when the system samples the DQ7 output, it may read the status or valid data. Even if the device has completed the Embedded Algorithm operations and DQ7 has a valid data, the data outputs on DQ0 – DQ6 may be still invalid. The valid data on DQ0 – DQ7 will be read on the successive read attempts.

The Data Polling feature is only active during the Embedded Programming Algorithm, Embedded Erase Algorithm, or page erase time-out (see "Command Definitions").

DQ6: Toggle Bit

The W39L512 also features the "Toggle Bit" as a method to indicate to the host system that the embedded algorithms are in progress or completed.

During an Embedded Program or Erase Algorithm cycle, successive attempts to read (#OE toggling) data from the device at any address will result in DQ6 toggling between one and zero. Once the Embedded Program or Erase Algorithm cycle is completed, DQ6 will stop toggling and valid data will be read on the next successive attempt. During programming, the Toggle Bit is valid after the rising edge of the fourth #WE pulse in the four write pulse sequence. For chip erase, the Toggle Bit is valid after the rising edge of the sixth #WE pulse in the six write pulse sequence. For page erase, the Toggle Bit is valid after the last rising edge of the page erase #WE pulse. The Toggle Bit is active during the page erase time-out.

Either #CE or #OE toggling will cause DQ6 to toggle.

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7. TABLE OF OPERATING MODES

Device Bus Operations

(V_{ID} = 12 ±0.5V)

MODE	PIN						
	#CE	#OE	#WE	A0	A1	A9	DQ0 - DQ7
Read	V_{IL}	V_{IL}	V_{IH}	A0	A1	A9	Dout
Write	V_{IL}	V_{IH}	V_{IL}	A0	A1	A9	Din
Standby	V_{IH}	X	X	X	X	X	High Z
Write Inhibit	X	V_{IL}	X	X	X	X	High Z/Dout
	X	X	V_{IH}	X	X	X	High Z/Dout
Output Disable	V_{IL}	V_{IH}	V_{IH}	X	X	X	High Z
Auto select Manufacturers ID	V_{IL}	V_{IL}	V_{IH}	V_{IL}	V_{IL}	V_{ID}	DA(hex)
Auto select Device ID	V_{IL}	V_{IL}	V_{IH}	V_{IH}	V_{IL}	V_{ID}	38h

Auto-select Codes (High Voltage Method)

(V_{ID} = 12 ±0.5V)

DESCRIPTION	#CE	#OE	#WE	A9	THE OTHER ADDRESS	DQ[7:0]
Manufacturer ID: Winbond	V_{IL}	V_{IL}	V_{IH}	V_{ID}	All Add = V_{IL}	DA(hex)
Device ID: W39L512	V_{IL}	V_{IL}	V_{IH}	V_{ID}	A1= V_{IH}, All other = V_{IL}	38h

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Command Definitions

COMMAND	NO. OF	1ST CYCLE		2ND CYCLE		3RD CYCLE		4TH CYCLE		5TH CYCLE		6TH CYCLE		7TH CYCLE	
DESCRIPTION	Cycles	Addr. [1]	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data
Read	1	A_{IN}	D_{OUT}												
Chip Erase	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	10		
Page Erase	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	PA[3]	50		
Byte Program	4	5555	AA	2AAA	55	5555	A0	A_{IN}	D_{IN}						
Top Boot Block Lockout –8KByte	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	70	FFFF	XX[4]
Bottom Boot Block Lockout - 8KByte	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	70	00000	XX[4]
Product ID Entry	3	5555	AA	2AAA	55	5555	90								
Product ID Exit [2]	3	5555	AA	2AAA	55	5555	F0								
Product ID Exit [2]	1	XXXX	F0												

Notes:

1. Address Format: A15 – A0 (Hex); Data Format: DQ7 – DQ0 (Hex)
2. Either one of the two Product ID Exit commands can be used.
3. PA: Page Address

    PA = FXXXh for Page 15
    PA = EXXXh for Page 14
    PA = DXXXh for Page 13
    PA = CXXXh for Page 12
    PA = BXXXh for Page 11
    PA = AXXXh for Page 10
    PA = 9XXXh for Page 9
    PA = 8XXXh for Page 8
    PA = 7XXXh for Page 7
    PA = 6XXXh for Page 6
    PA = 5XXXh for Page 5
    PA = 4XXXh for Page 4
    PA = 3XXXh for Page 3
    PA = 2XXXh for Page 2
    PA = 1XXXh for Page 1
    PA = 0XXXh for Page 0

4. XX: Don't care

Embedded Programming Algorithm
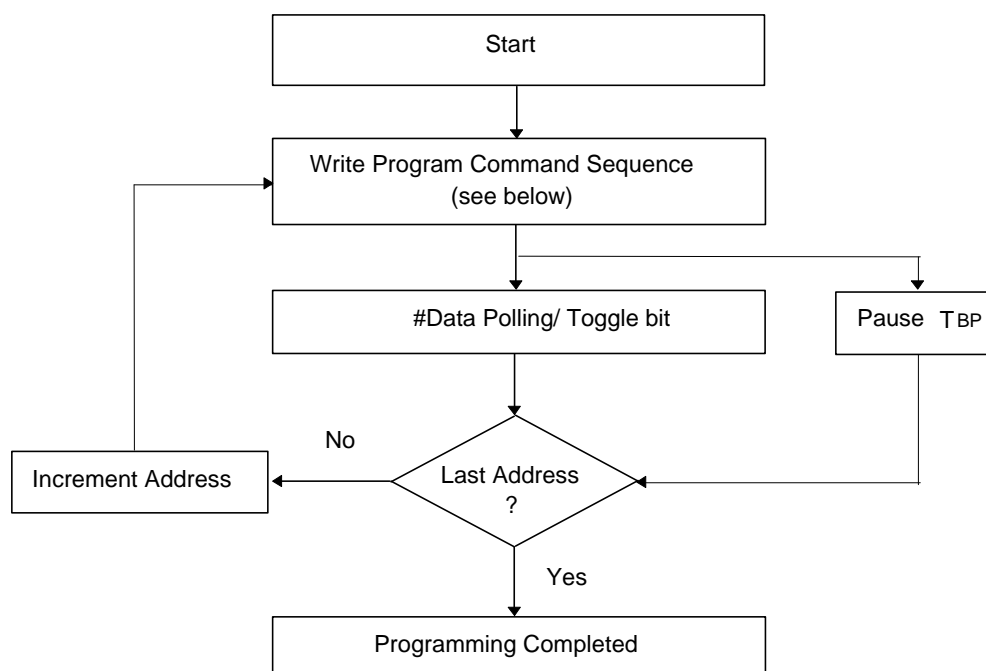
```
                        ┌─────────────────────┐
                        │        Start        │
                        └─────────────────────┘
                                   │
                                   ▼
              ┌──────────────────────────────────────┐
              │   Write Program Command Sequence      │◄──────┐
              │            (see below)                │       │
              └──────────────────────────────────────┘       │
                         │                                    │
              ┌──────────┴───────────────┐                    │
              ▼                           ▼                    │
   ┌─────────────────────────┐   ┌─────────────────┐          │
   │ #Data Polling/ Toggle bit│   │  Pause  T BP    │          │
   └─────────────────────────┘   └─────────────────┘          │
              │                           │                    │
              ▼                           │                    │
        No  ◇───────────◇                 │                    │
   ┌──────────────────┐ Last Address ◄────┘                    │
   │ Increment Address │◄───  ?                                │
   └──────────────────┘     ◇────◇                             │
              │                │                               │
              └────────────────┘                               │
                           Yes │                               │
                               ▼                               │
              ┌──────────────────────────────────────┐         │
              │        Programming Completed          │         │
              └──────────────────────────────────────┘         │
```

Program Command Sequence (Address/Command):

```
              ┌──────────────────────────────────────┐
              │              5555H/AAH               │
              └──────────────────────────────────────┘
                               │
                               ▼
              ┌──────────────────────────────────────┐
              │              2AAAH/55H               │
              └──────────────────────────────────────┘
                               │
                               ▼
              ┌──────────────────────────────────────┐
              │              5555H/A0H               │
              └──────────────────────────────────────┘
                               │
                               ▼
              ┌──────────────────────────────────────┐
              │     Program Address/Program Data      │
              └──────────────────────────────────────┘
```

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Embedded Erase Algorithm

```
                          ┌─────────────────────┐
                          │        Start        │
                          └─────────────────────┘
                                     │
                                     ▼
                          ┌─────────────────────┐
                          │ Write Erase Command │
                          │ Sequence (see below)│
                          └─────────────────────┘
                                     │
                          ┌──────────┴──────────────────────┐
                          ▼                                  ▼
              ┌──────────────────────────┐      ┌──────────────────────┐
              │ #Data Polling or Toggle  │      │   Pause TEC/TPEC      │
              │ Bit Successfully         │      └──────────────────────┘
              │ Completed                │                  │
              └──────────────────────────┘                  │
                          │◄────────────────────────────────┘
                          ▼
              ┌──────────────────────────┐
              │    Erasure Completed     │
              └──────────────────────────┘
```

Chip Erase Command Sequence (Address/Command):

```
┌──────────────────┐
│    5555H/AAH     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    2AAAH/55H     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    5555H/80H     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    5555H/AAH     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    2AAAH/55H     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    5555H/10H     │
└──────────────────┘
```
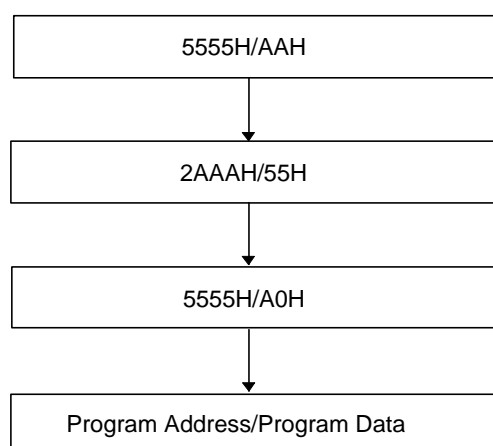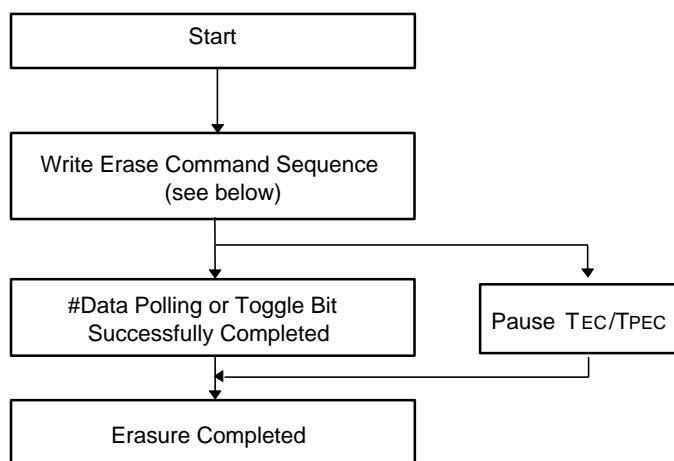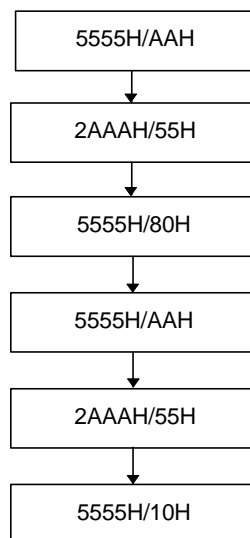
Individual Page Erase Command Sequence (Address/Command):

```
┌──────────────────┐
│    5555H/AAH     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    2AAAH/55H     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    5555H/80H     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    5555H/AAH     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│    2AAAH/55H     │
└──────────────────┘
         │
         ▼
┌──────────────────┐
│  Page Address/50H│
└──────────────────┘
```

Embedded #Data Polling Algorithm

```
                    ┌──────────┐
                    │  Start   │
                    └────┬─────┘
                         │
                         ▼
              ┌──────────────────┐      VA = Byte address for programming
         ┌───▶│   Read Byte      │        = Any of the page addresses within
         │    │  (DQ0 - DQ7)     │          the page being erased during page
         │    │  Address = VA    │          erase operation
         │    └────────┬─────────┘         =Any of the device addresses being erased
         │             │                     during chip operation
         │             ▼
    No   │        ╱─────────╲
         └───────◇ DQ7 = Data ◇
                  ╲    ?     ╱
                    ╲─────╱
                       │ Yes
                       ▼
                  ┌────────┐
                  │  Pass  │
                  └────────┘
```
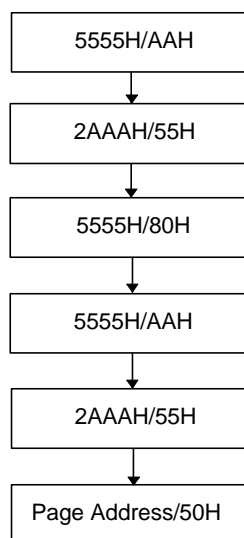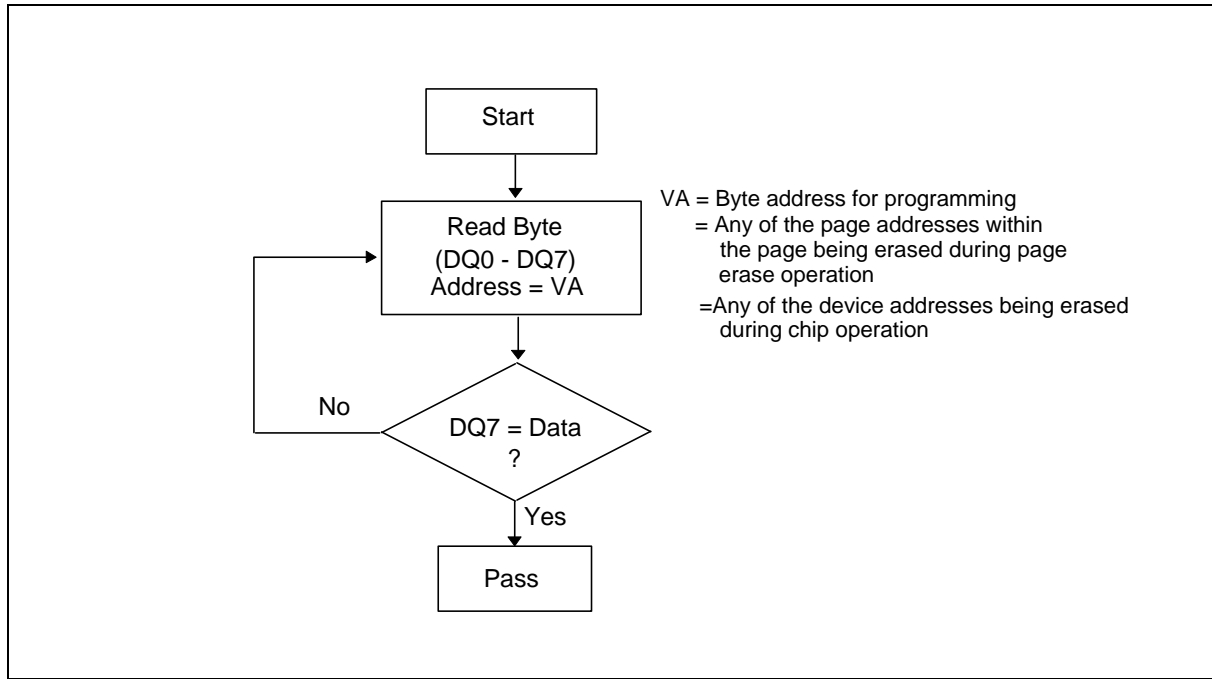
Embedded Toggle Bit Algorithm

```
                    ┌──────────┐
                    │  Start   │
                    └────┬─────┘
                         │
                         ▼
              ┌────────────────────┐
         ┌───▶│    Read Byte       │
         │    │   (DQ0 - DQ7)      │
         │    │ Address = Don't Care│
         │    └─────────┬──────────┘
         │              │
    Yes  │              ▼
         │         ╱──────────╲
         └────────◇ DQ6 = Toggle ◇
                   ╲     ?      ╱
                     ╲──────╱
                        │ No
                        ▼
                   ┌────────┐
                   │  Pass  │
                   └────────┘
```
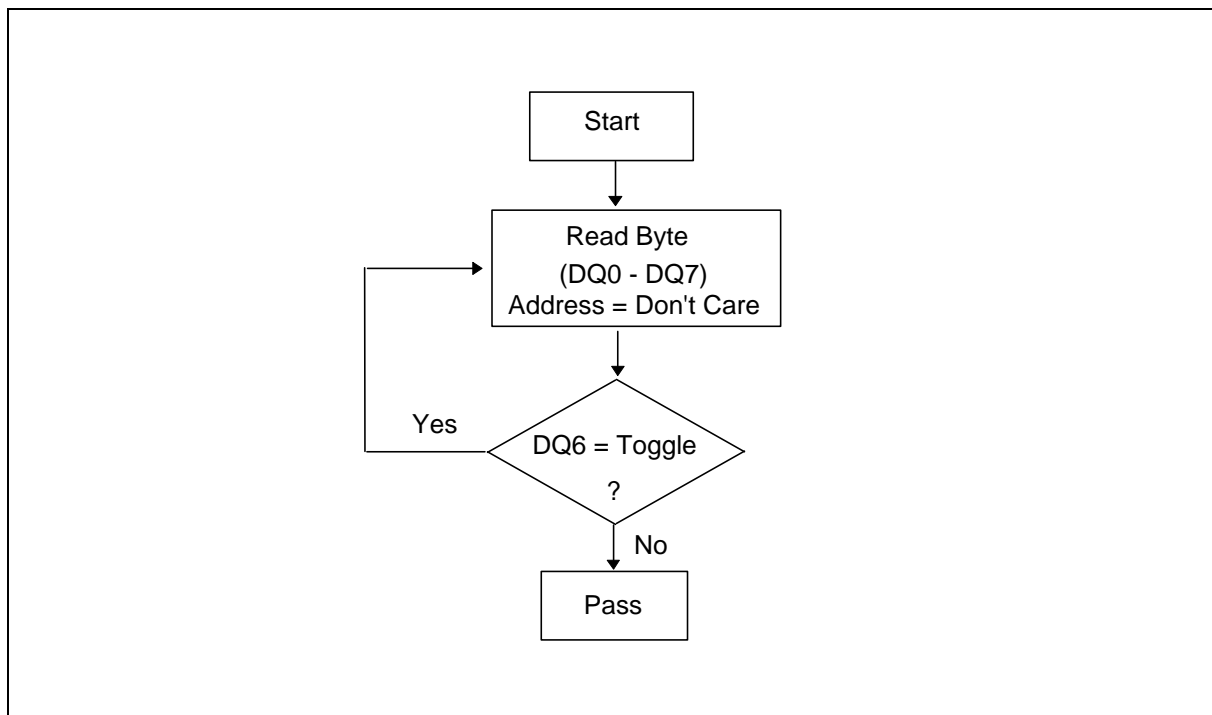
Boot Block Lockout Enable Flow Chart

**Boot Block Lockout
Feature Set Flow**

Load data AA
to
address 5555

Load data 55
to
address 2AAA

Load data 80
to
address 5555

Load data AA
to
address 5555

Load data 55
to
address 2AAA

Load data 70
to
address 5555   70 to lcok 8K Boot Block

Load data XX
to
address FFFF/0 h   FFFF(XX) to lock Top Boot Block
0000(XX) to lock Bottom Boot Block

Pause 2 mS

Exit
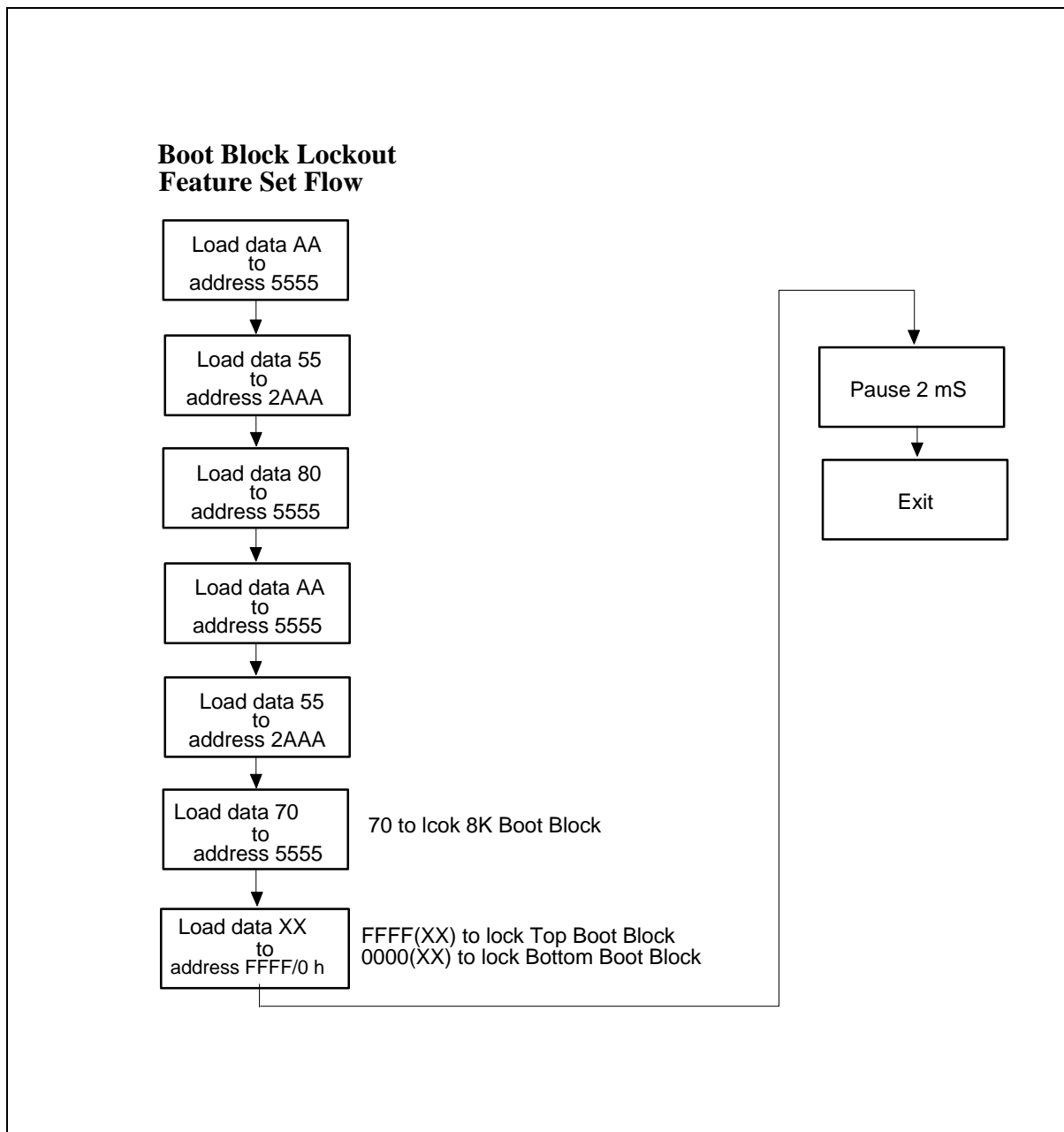
Software Product Identification and Boot Block Lockout Detection Flow Chart

Product Identification Entry (1)

- Load data AA to address 5555
- Load data 55 to address 2AAA
- Load data 90 to address 5555
- Pause 10 μS

Product Identification and Boot Block Lockout Mode (3)

- Read address = 0000 data = DA (2)
- Read address = 0001 data = 38 (2)
- Read address= 02/FFF2 for Bottom/Top data: in DQ1 = "1" or "0" for 8K Boot Block (4)

Product Identification Exit(6)

- Load data AA to address 5555
- Load data 55 to address 2AAA
- Load data F0 to address 5555
- Pause 10 μS
- Normal Mode (5)

Notes for software product identification/boot block lockout detection:

(1) Data Format: DQ7 – DQ0 (Hex); Address Format: A15 – A0 (Hex)

(2) A1 – A15 = V_{IL}; manufacture code is read for A0 = V_{IL}; device code is read for A0 = V_{IH}.

(3) The device does not remain in identification and boot block lockout detection mode if power down.

(4) If the output data in DQ0 or DQ1= " 1 " the boot block programming lockout feature is activated; if the output data in DQ0 or DQ1= " 0," the lockout feature is inactivated and the matched boot block can be programmed.

(5) The device returns to standard operation mode.

(6) Optional 1-byte cycle (write F0 hex at XXXX address) can be used to exit the product identification/boot block lockout detection.

8. DC CHARACTERISTICS

Absolute maximum Ratings

PARAMETER	RATING	UNIT
Power Supply Voltage to Vss Potential	-2.0 to +4.6	V
Operating Temperature	0 to +70	°C
Storage Temperature	-65 to +125	°C
Voltage on Any Pin to Ground Potential Except A9	-2.0 to +4.6	V
Voltage on A9 Pin to Ground Potential	-2.0 to +13.0	V

Note: Exposure to conditions beyond those listed under Absolute maximum Ratings may adversely affect the life and reliability of the device.

DC Operating Characteristics

(V_{DD} = 3.3V ±0.3V, V_{SS} = 0V, T_A = 0 to 70° C)

PARAMETER	SYM.	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Power Supply Current	I_{DD}	#CE = #OE = V_{IL}, #WE = V_{IH}, all DQs open, Address inputs = V_{IL}/V_{IH}, at f = 5 MHz	-	10	20	mA
Standby V_{DD} Current (TTL input)	I_{SB1}	#CE = V_{IH}, all DQs open Other inputs = V_{IL}/V_{IH}	-	1	2	mA
Standby V_{DD} Current (CMOS input)	I_{SB2}	#CE = V_{DD} -0.3V, all DQs open Other inputs = V_{DD} -0.3V/ V_{SS}	-	15	50	µA
Input Leakage Current	I_{LI}	V_{IN} = V_{SS} to V_{DD}	-	-	1	µA
Output Leakage Current	I_{LO}	V_{OUT} = V_{SS} to V_{DD}	-	-	1	µA
Input Low Voltage	V_{IL}	-	-0.3	-	0.8	V
Input High Voltage	V_{IH}	-	2.0	-	V_{DD} +0.5	V
Output Low Voltage	V_{OL}	I_{OL} = 2.1 mA	-	-	0.45	V
Output High Voltage	V_{OH}	I_{OH} = -0.4 mA	2.4	-	-	V

Pin Capacitance

(V_{DD} = 3.3V, T_A = 25° C, f = 1 MHz)

PARAMETER	SYMBOL	CONDITIONS	TYP.	MAX.	UNIT
Input Capacitance	C_{IN}	V_{IN} = 0V	6	8	pF
Output Capacitance	C_{OUT}	V_{OUT} = 0V	10	12	pF

9. AC CHARACTERISTICS

AC Test Conditions

PARAMETER	CONDITIONS
Input Pulse Levels	0V to 3V
Input Rise/Fall Time	<5 nS
Input/Output Timing Level	1.5V/1.5V
Output Load	1 TTL Gate and C_L = 30 pF

AC Test Load and Waveform
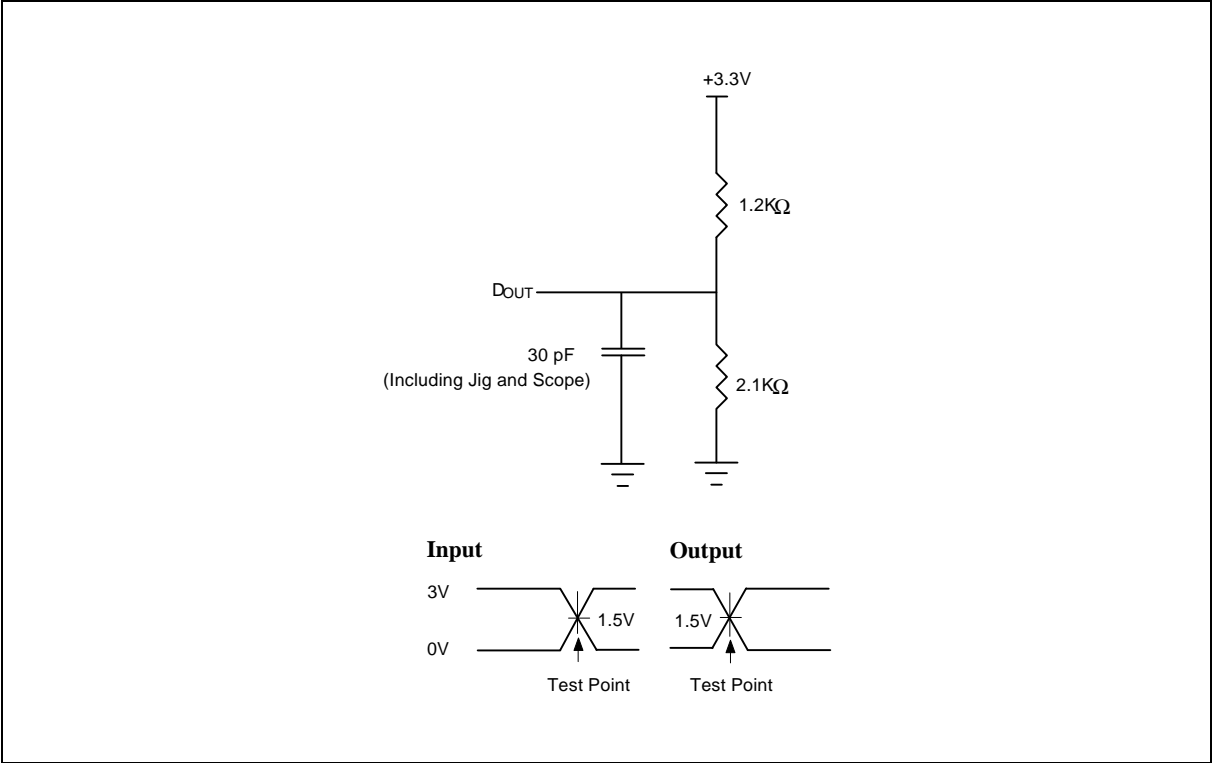
AC Characteristics, continued

Read Cycle Timing Parameters

(V_{DD} = 3.3V $\pm$0.3V, V_{SS} = 0V, T_A = 0 to 70° C)

PARAMETER	SYM.	W39L512-70		W39L512-90		UNIT
		MIN.	MAX.	MIN.	MAX.	
Read Cycle Time	T_{RC}	70	-	90	-	nS
Chip Enable Access Time	T_{CE}	-	70	-	90	nS
Address Access Time	T_{AA}	-	70	-	90	nS
Output Enable Access Time	T_{OE}	-	35	-	45	nS
#CE Low to Active Output	T_{CLZ}	0	-	0	-	nS
#OE Low to Active Output	T_{OLZ}	0	-	0	-	nS
#CE High to High-Z Output	T_{CHZ}	-	25	-	25	nS
#OE High to High-Z Output	T_{OHZ}	-	25	-	25	nS
Output Hold from Address Change	T_{OH}	0	-	0	-	nS

Write Cycle Timing Parameters

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Address Setup Time	T_{AS}	0	-	-	nS
Address Hold Time	T_{AH}	40	-	-	nS
#WE and #CE Setup Time	T_{CS}	0	-	-	nS
#WE and #CE Hold Time	T_{CH}	0	-	-	nS
#OE High Setup Time	T_{OES}	0	-	-	nS
#OE High Hold Time	T_{OEH}	0	-	-	nS
#CE Pulse Width	T_{CP}	100	-	-	nS
#WE Pulse Width	T_{WP}	100	-	-	nS
#WE High Width	T_{WPH}	100	-	-	nS
Data Setup Time	T_{DS}	40	-	-	nS
Data Hold Time	T_{DH}	10	-	-	nS
Byte Programming Time	T_{BP}	-	35	50	μS
Chip Erase Cycle Time	T_{EC}	-	50	100	mS
Page Erase Cycle Time	T_{EP}	-	12.5	25	mS

Note: All AC timing signals observe the following guidelines for determining setup and hold times:
    (a) High level signal's reference level is V_{IH} and (b) low level signal's reference level is V_{IL}.

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AC Characteristics, continued

Power-up Timing

PARAMETER	SYMBOL	TYPICAL	UNIT
Power-up to Read Operation	T$_{PU}$. READ	100	μS
Power-up to Write Operation	T$_{PU}$. WRITE	5	mS

Data Polling and Toggle Bit Timing Parameters

PARAMETER	SYM.	W39L512-70		W39L512-90		UNIT
		MIN.	MAX.	MIN.	MAX.	
#OE to Data Polling Output Delay	T$_{OEP}$	-	35	-	45	nS
#CE to Data Polling Output Delay	T$_{CEP}$	-	70	-	90	nS
#OE to Toggle Bit Output Delay	T$_{OET}$	-	35	-	45	nS
#CE to Toggle Bit Output Delay	T$_{CET}$	-	70	-	90	nS

10. TIMING WAVEFORMS

Read Cycle Timing Diagram
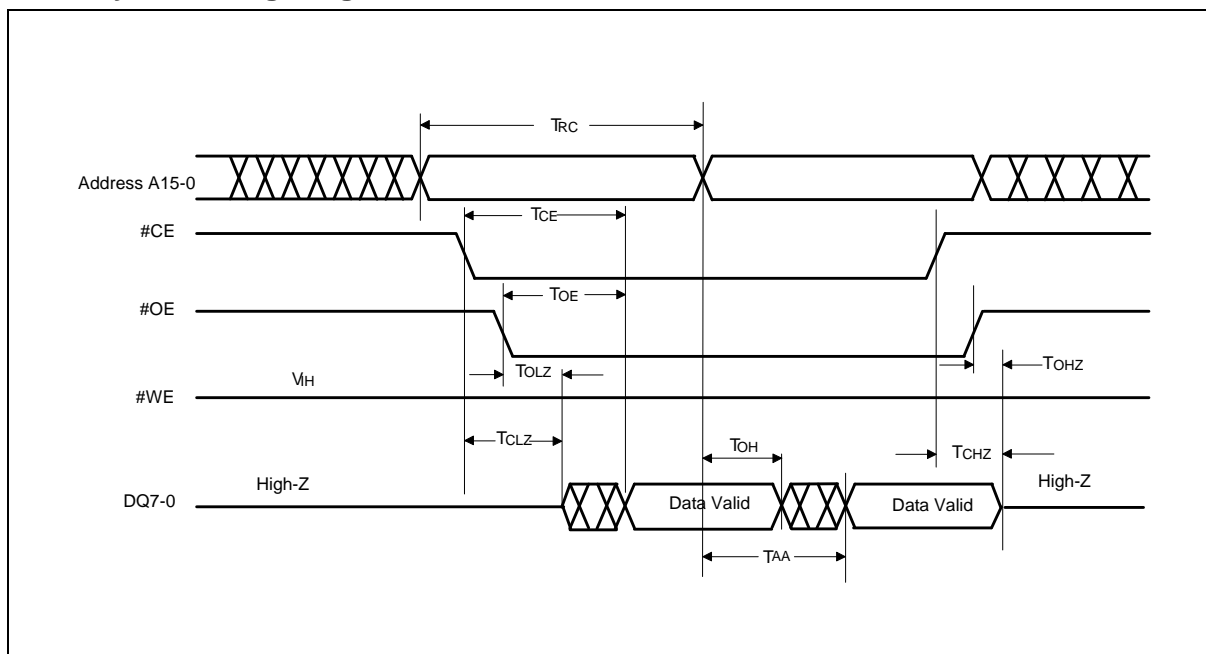
#WE Controlled Command Write Cycle Timing Diagram
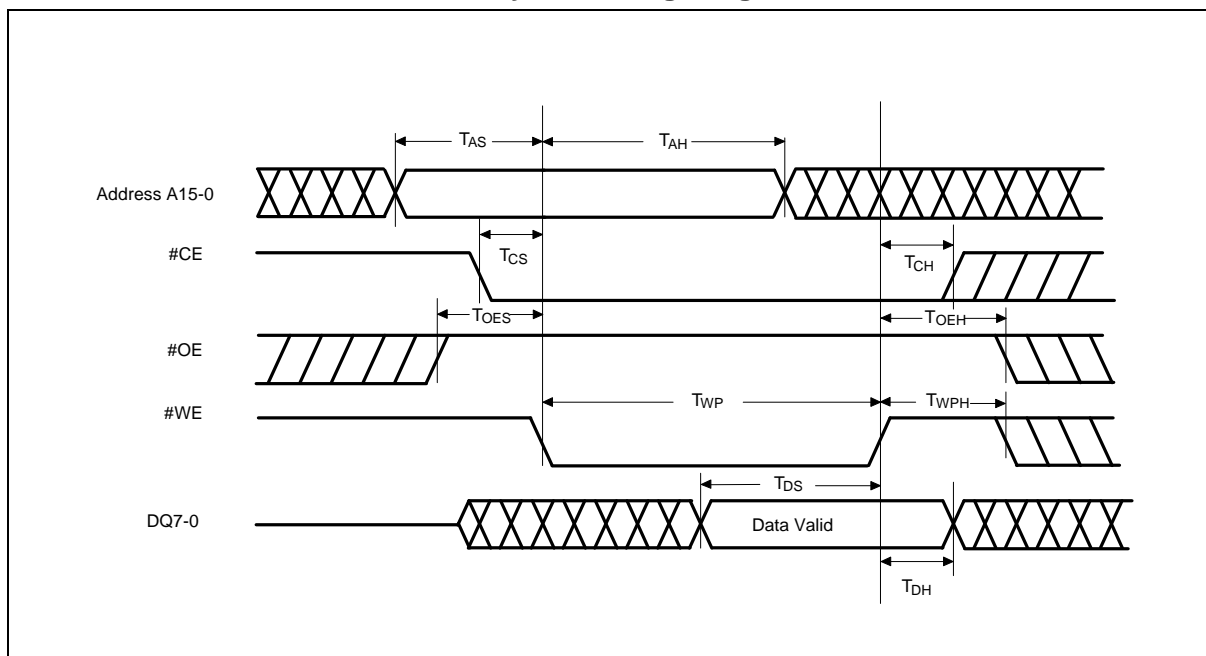
Timing Waveforms, continued

#CE Controlled Command Write Cycle Timing Diagram
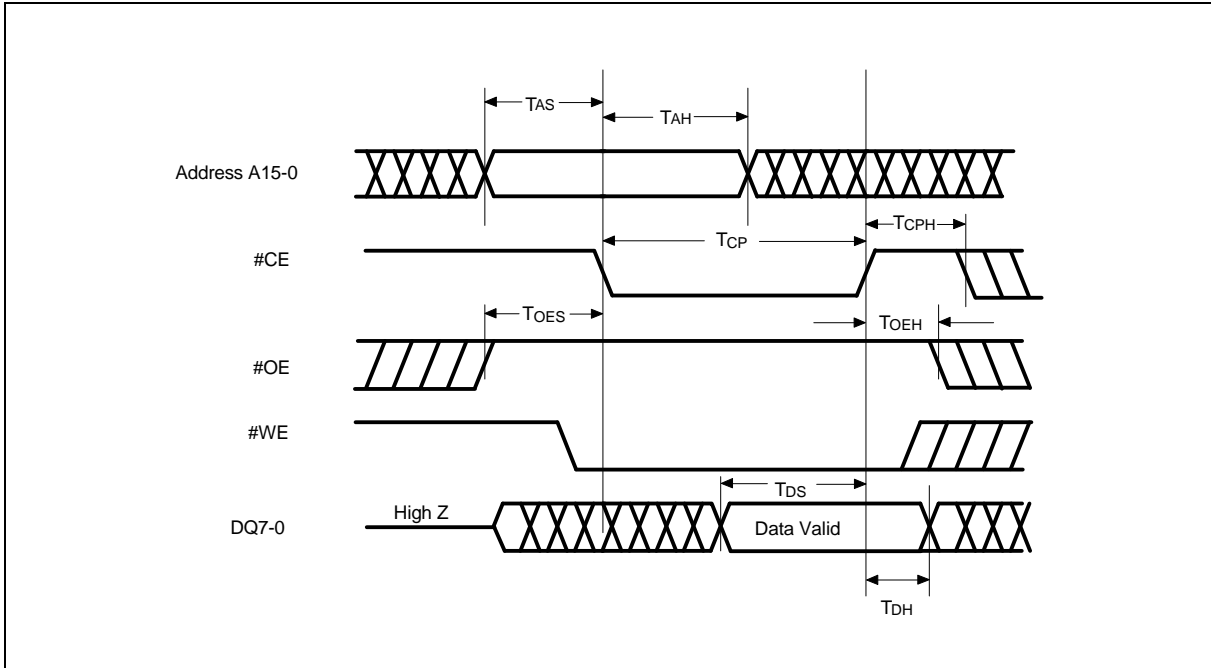
Chip Erase Timing Diagram
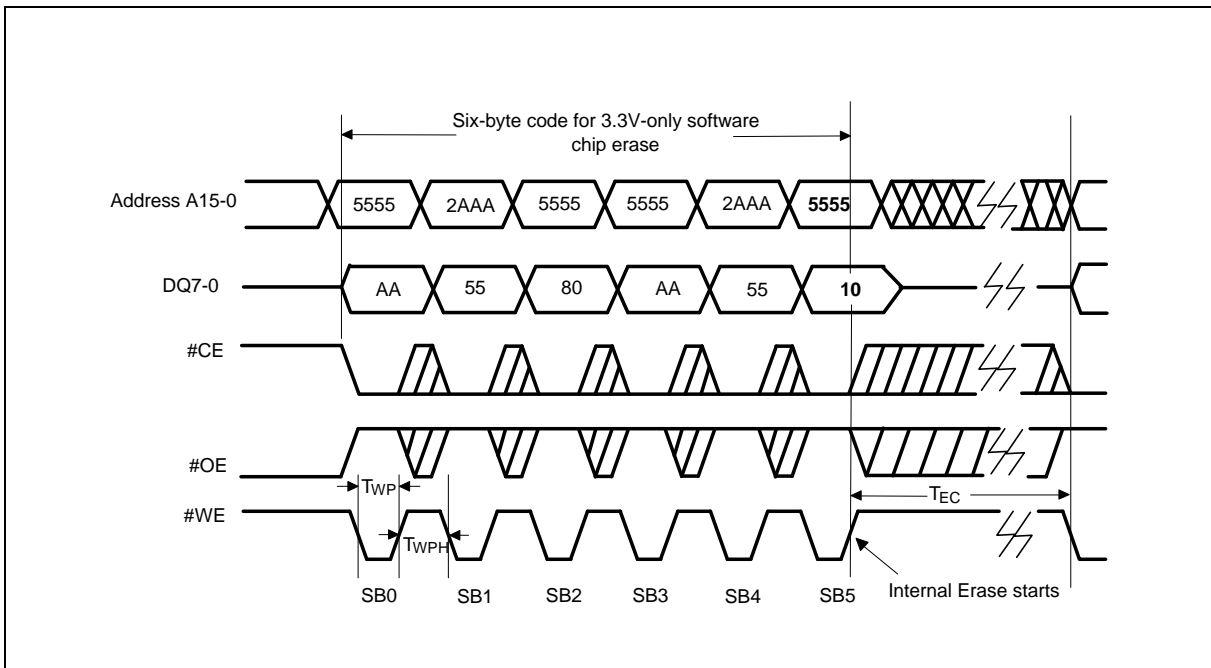
Timing Waveforms, continued

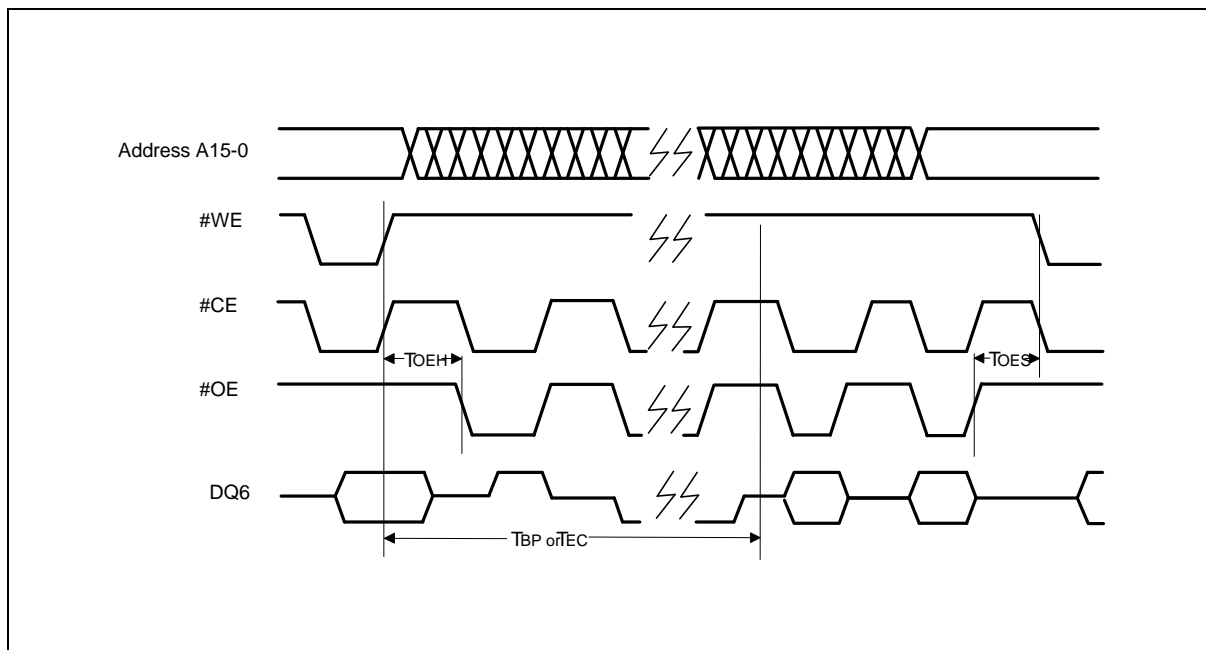## Page Erase Timing Diagram

PA = Page Address

Please refer to page 9 for detail information
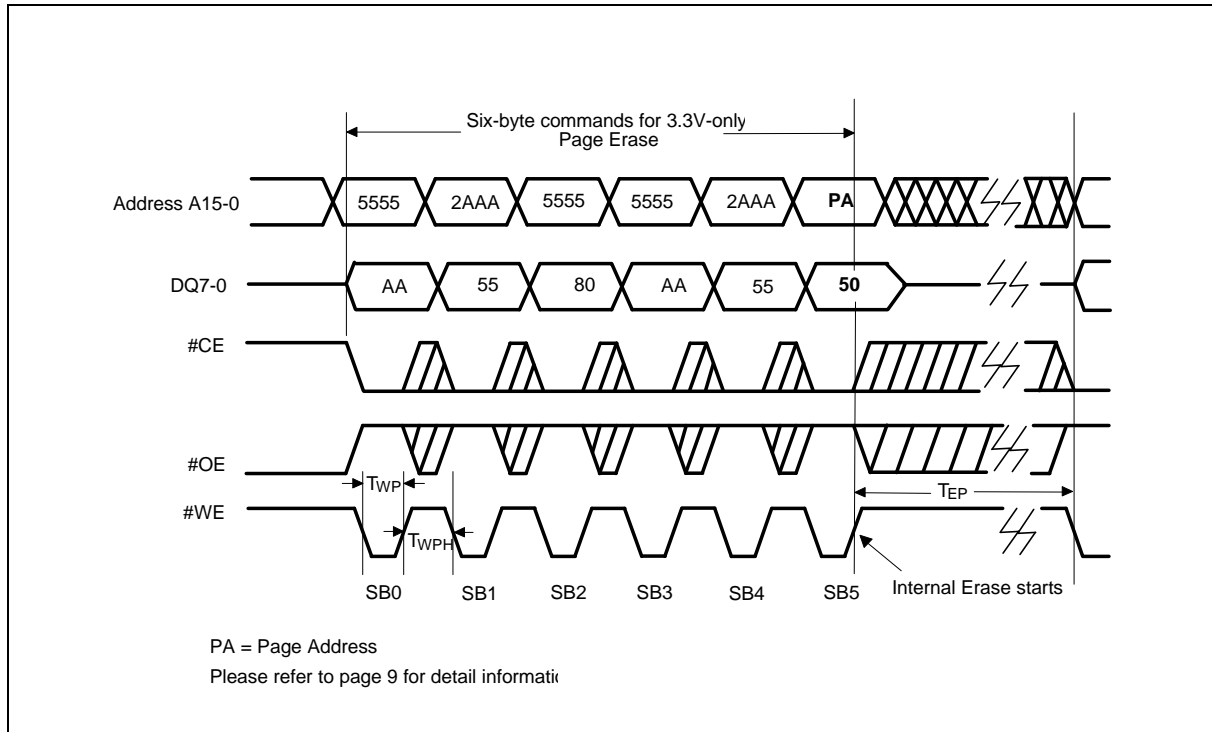
#DATA Polling Timing Diagram
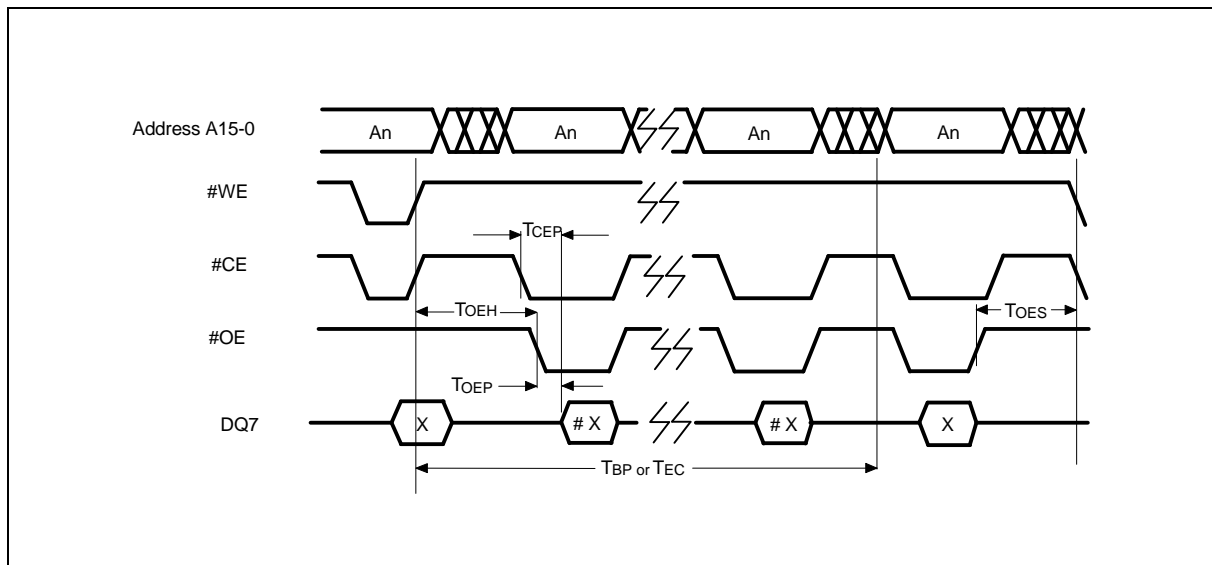
Timing Waveforms, continued

Toggle Bit Timing Diagram

11. ORDERING INFORMATION

PART NO.	ACCESS TIME (nS)	POWER SUPPLY CURRENT MAX. (mA)	STANDBY V_{DD} CURRENT MAX. (mA)	PACKAGE	CYCLE
W39L512P-70	70	20	2	32-pin PLCC	1K
W39L512P-90	90	20	2	32-pin PLCC	1K
W39L512Q-70	70	20	2	32-pin STSOP	1K
W39L512Q-90	90	20	2	32-pin STSOP	1K
W39L512P-70B	70	20	2	32-pin PLCC	10K
W39L512P-90B	90	20	2	32-pin PLCC	10K
W39L512Q-70B	70	20	2	32-pin STSOP	10K
W39L512Q-90B	90	20	2	32-pin STSOP	10K

Notes:

1. Winbond reserves the right to make changes to its products without prior notice.

2. Purchasers are responsible for performing appropriate quality assurance testing on products intended for use in applications where personal injury might occur as a consequence of product failure.

12. HOW TO READ THE TOP MARKING

Example: The top marking of 32-pin PLCC W39L512P-70
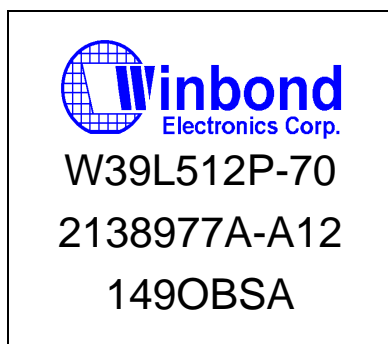
1st line: winbond logo

2nd line: the part number: W39L512P-70

3rd line: the lot number

4th line: the tracking code: 149 O B SA

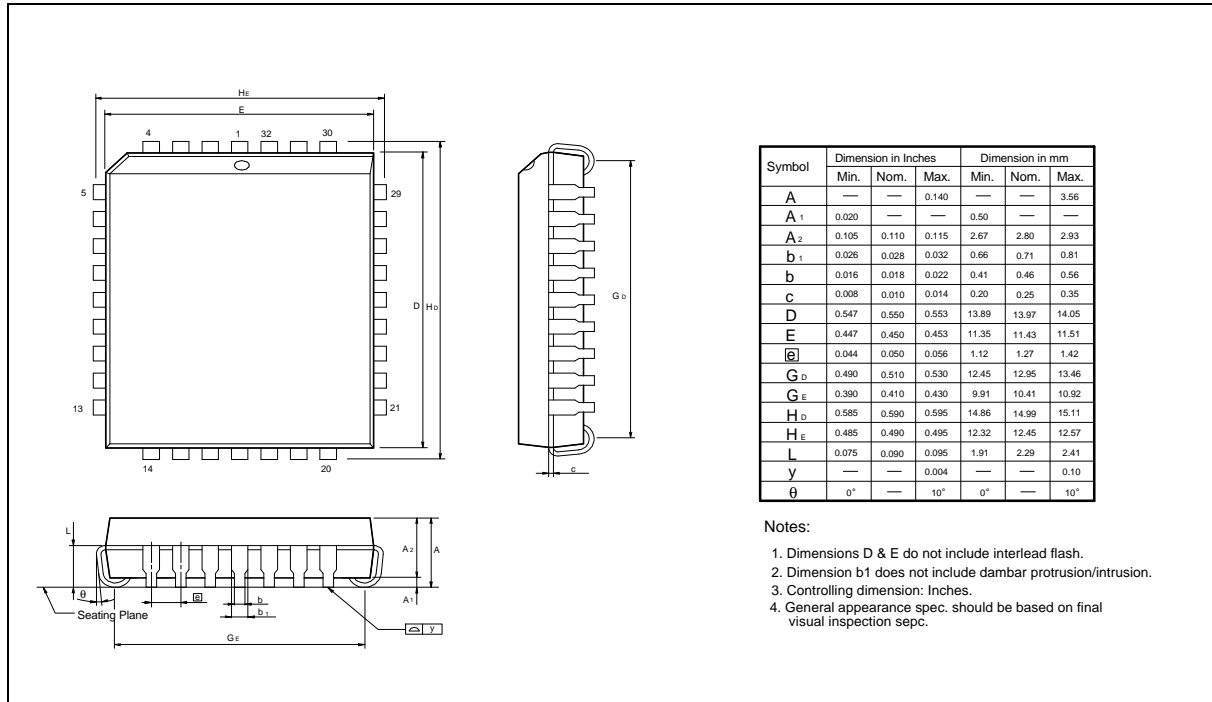   149: Packages made in '01, week 49

        O: Assembly house ID: A means ASE, O means OSE, ...etc.

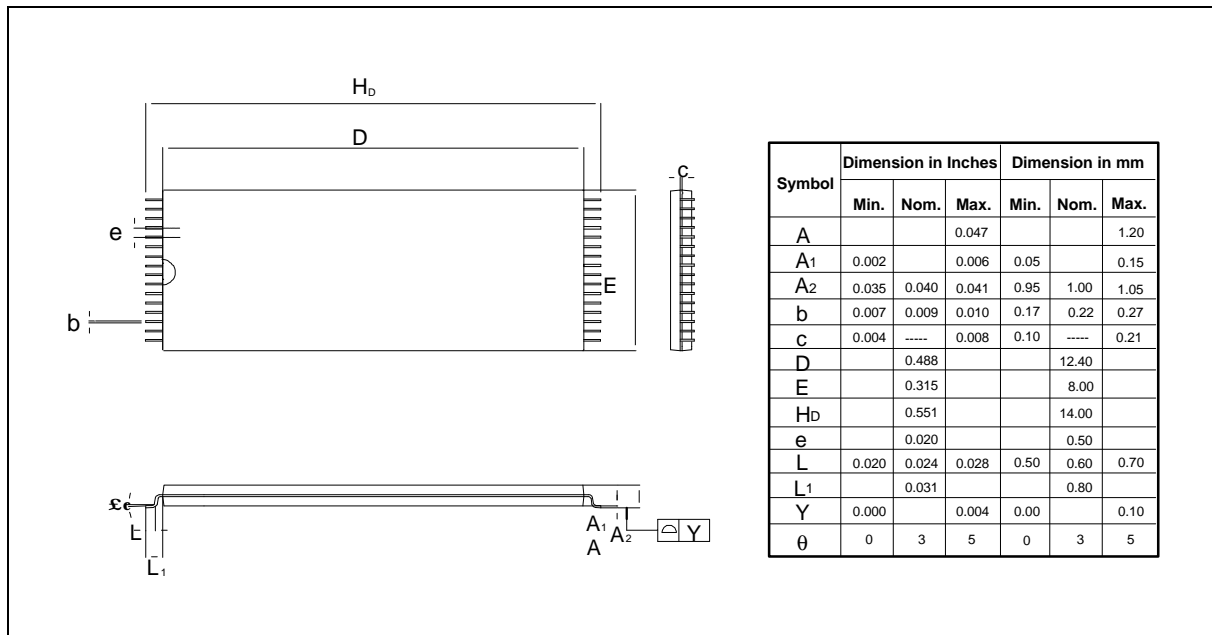   B: IC revision; A means version A, B means version B, ...etc.

        SA: Process code

13. PACKAGE DIMENSIONS

32-pin PLCC

Symbol	Dimension in Inches			Dimension in mm		
	Min.	Nom.	Max.	Min.	Nom.	Max.
A	—	—	0.140	—	—	3.56
A1	0.020	—	—	0.50	—	—
A2	0.105	0.110	0.115	2.67	2.80	2.93
b1	0.026	0.028	0.032	0.66	0.71	0.81
b	0.016	0.018	0.022	0.41	0.46	0.56
c	0.008	0.010	0.014	0.20	0.25	0.35
D	0.547	0.550	0.553	13.89	13.97	14.05
E	0.447	0.450	0.453	11.35	11.43	11.51
e	0.044	0.050	0.056	1.12	1.27	1.42
GD	0.490	0.510	0.530	12.45	12.95	13.46
GE	0.390	0.410	0.430	9.91	10.41	10.92
HD	0.585	0.590	0.595	14.86	14.99	15.11
HE	0.485	0.490	0.495	12.32	12.45	12.57
L	0.075	0.090	0.095	1.91	2.29	2.41
y	—	—	0.004	—	—	0.10
θ	0°	—	10°	0°	—	10°

Notes:

1. Dimensions D & E do not include interlead flash.
2. Dimension b1 does not include dambar protrusion/intrusion.
3. Controlling dimension: Inches.
4. General appearance spec. should be based on final visual inspection sepc.

32-pin STSOP (8 x 14 mm)

Symbol	Dimension in Inches			Dimension in mm		
	Min.	Nom.	Max.	Min.	Nom.	Max.
A			0.047			1.20
A1	0.002		0.006	0.05		0.15
A2	0.035	0.040	0.041	0.95	1.00	1.05
b	0.007	0.009	0.010	0.17	0.22	0.27
c	0.004	-----	0.008	0.10	-----	0.21
D		0.488			12.40	
E		0.315			8.00	
HD		0.551			14.00	
e		0.020			0.50	
L	0.020	0.024	0.028	0.50	0.60	0.70
L1		0.031			0.80	
Y	0.000		0.004	0.00		0.10
θ	0	3	5	0	3	5

14. VERSION HISTORY

VERSION	DATE	PAGE	DESCRIPTION
A1	June 4, 2002	-	Initial Issued
A2	July 9, 2002	11	Remove Block Erase from the Embedded Erase Algorithm
		12	Correct Embedded #Data Polling Algorithm

Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:
- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits,General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:
- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.

Как с нами связаться

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